Supporting Information

Operando Raman Spectroscopy of Amorphous Molybdenum Sulfide (MoS_x) during the Electrochemical Hydrogen Evolution Reaction: Identification of Sulfur Atoms as Catalytically Active Sites for H⁺ Reduction

Yilin Deng,[†] Louisa Rui Lin Ting,^{†,‡} Perlin Hui Lin Neo,[†] Yin-Jia Zhang,[§]

Andrew A Peterson^I and Boon Siang Yeo^{*,†,‡}

[†]Department of Chemistry, Faculty of Science, National University of Singapore, 3 Science Drive 3, Singapore 117543

[‡]Solar Energy Research Institute of Singapore, National University of Singapore, 7 Engineering Drive 1, Singapore 117574.

[§]Department of Chemistry, Brown University, 324 Brook Street, Providence, Rhode Island 02912, United States

School of Engineering, Brown University, 184 Hope Street, Providence, Rhode Island 02912, United States

*Author to whom correspondence should be addressed to: <u>chmyeos@nus.edu.sg</u>, Fax: +65 6779 1691, Tel: +65 6516 2836

S1. Curve fitting parameters, assignment and quantification of XPS signals of MoS_x-AE and

MoS_x-CE catalysts

All the XPS peak assignments are summarized in Table S1. The Mo 3d spectra were fitted using a 3.2 eV separation between the $3d_{5/2}$ and $3d_{3/2}$ signals. The ratio of their peak areas was 3:2. The full width at half maximum (FWHM) for each pair of Mo 3d peaks was kept constant.¹ For the S 2p spectra, the peak separation was 1.2 eV between the $2p_{3/2}$ and $2p_{1/2}$ signals. The ratio of their peak areas was kept constant.¹ For the S 2p spectra, the full width at half maximum (FWHM) for each pair of S 2p peaks was kept constant.¹

By normalizing the signals against their specific relative sensitivity factors (RSF), the ratios of Mo: S could be derived from their relative peak areas. For example, in MoS_x -AE, the areas of the Mo 3d and S 2p peaks were 23722 and 14970 A.U. The relative sensitivity factors (RSF) for Mo 3d and S 2p are 3.321 and 0.668, respectively.

Hence, in MoS_x-AE the ratio of Mo: S atoms = $\frac{23722}{3.321}$: $\frac{14970}{0.668}$ = 1:3.1

The ratios of S atoms with high and low electron binding energies could also be similarly derived. The S 2p peak could be further deconvoluted into low electron binding energy S and high electron binding energy S peaks, with the areas of 7275 and 7695 respectively. The ratio of low electron binding energy S: high electron binding energy S atoms = $\frac{7275}{0.668} : \frac{7695}{0.668} = 49:51$.

Signal	Binding Energies (eV)	Assignment	References
Mo ^{IV}	229.8 $(3d_{5/2})$, 233.0 $(3d_{3/2})$	Mo centre of Mo-S catalysts	2-4
Mo ^{VI}	232.4 (3d _{5/2}), 235.6 (3d _{3/2})	MoO ₃	2,5
S atoms with lower BE	162.5 (2p _{3/2}), 163.7 (2p _{1/2})	Unsaturated S ²⁻ in amorphous MoS _x Terminal S ₂ ²⁻ in amorphous MoS _x	2,6-8
S atoms with higher BE	163.8 (2p _{3/2}), 165.0 (2p _{1/2})	Apical S^{2-} in amorphous MoS_x Bridging S_2^{2-} in amorphous MoS_x	2,4,6,8

Table S1: Assignment of XPS Signals of MoS_x-AE and MoS_x-CE

S2. Electrochemical/Raman Setup

The schematic diagram of the electrochemical/Raman spectroscopy setup is shown in Figure S1.



Figure S1: Schematic diagram of the electrochemical/Raman spectroscopy setup.

Each spectrum presented in this work is an average of three continuously acquired spectra with a collection time of 10 s each, except for that of the MoS_x -AE sample at 0.40 V, 0.28 V and 0.18 V (all potentials are vs. RHE) during the cathodic sweep of CV, which are an average of 9 spectra with a collection time of 10 s each. The Raman spectrum of crystalline MoS_2 (99%, Sigma Aldrich) is an average of 16 continuously acquired spectra with collection time of 5 s each.

S3. Atom % D in deuterated electrolyte (1 M DClO₄)

The 1 M DClO₄ was prepared from 8.625 mL of HClO₄ (70%, Sigma Aldrich) and 91.38 mL of D_2O (99.9 atom % D, Cambridge Isotope).

Densities of the 70% HClO₄ and the commercial D_2O at 25 °C are 1.664 g/mL and 1.107 g/mL respectively.

Molar mass:

 $M(\text{HClO}_4) = 1.01 + 35.45 + 16.00 \times 4 = 100.46 \text{ g/mol}$ $M(\text{H}_2\text{O}) = 1.01 \times 2 + 16.00 = 18.02 \text{ g/mol}.$ $M(\text{D}_2\text{O}) = 2.01 \times 2 + 16.00 = 20.02 \text{ g/mol}.$

In 8.625 mL of 70% HClO₄, the number of moles of HClO₄ and H₂O are:

Number of moles of HClO₄ = $\frac{m(HClO_4)}{M(HClO_4)}$ = $\frac{8.625mL \times 1.664 \text{ g/mL} \times 70\%}{100.46 \text{ g/mol}}$ = 0.10 mol Number of moles of H₂O = $\frac{m(H_2O)}{M(H_2O)}$ = $\frac{8.625mL \times 1.664 \text{ g/mL} \times 30\%}{18.02 \text{ g/mol}}$ = 0.24 mol

Therefore, the total number of moles of H from 70% HClO₄:

 $= 0.10 \text{ mol} + 0.24 \times 2 \text{ mol} = 0.58 \text{ mol}$

The number of moles of both H and D from the commercial D₂O:

 $= \frac{m(D_2O)}{M(H_2O) \times 0.1\% + M(D_2O) \times 99.9\%} \times 2 = \frac{91.38 \text{ mL} \times 1.107 \text{ g/mL}}{18.02 \text{ g/mol} \times 0.1\% + 20.02 \text{ g/mol} \times 99.9\%} \times 2 = 10.11 \text{ mol}$

The number of moles of H from the commercial D_2O :

 $= 10.11 \text{ mol} \times 0.1\% = 0.01 \text{ mol}$

Hence, the atom % H in the 1 M DClO₄:

 $= \frac{\text{Total number of moles of H}}{\text{Total number of moles of both H and D}} = \frac{0.58\text{mol}+0.01\text{ mol}}{0.58\text{mol}+10.11\text{ mol}} = 5.5\%$

Therefore, the atom % D is:

100% - 5.5% = 94.5%

S4. Calculation of turnover frequencies

S4.1. Determination of the number of active sites in MoS_x -AE and MoS_x -CE using oxidative stripping

Cyclic voltammetry stripping was performed to oxidize the deposited films (Figure S2).⁹ The HER performances of both samples were negligible after oxidative stripping to 1.3 V vs. RHE. This indicates that the active sites of the deposited films have been removed. Hence, the integrated charges beneath the oxidative peaks represent the amount of active sites in the films.^{9,10}



Figure S2: Linear sweep voltammograms of (a) MoS_x -AE and (b) MoS_x -CE before and after CV stripping to 1.3 V vs RHE in 1 M HClO₄. Insets show the corresponding CV stripping curves. Scan rate: 2 mV/s.

S4.2. Calculation of turnover frequencies

Using one measurement of MoS_x -AE catalyst as an example:

The turnover frequency (TOF) is expressed as:

 $TOF = \frac{Number of H_2 \text{ molecules evolved per second}}{Number of Active Sites}$

Number of H_2 molecules evolved per second (assuming 100% Faradic efficiency in the HER process)⁹:

 $=\frac{i}{96485 C \text{ per mole } e^-} \times \frac{6.023 \times 10^{23} e^- \text{ per mole}}{2 e^- \text{ per molecule of } H_2}$

(where *i* is the current in amperes).

At an overpotential of 200mV, observed HER current in Figure S2a is $i = 1.51 \times 10^{-3}$ A.

The number of active sites, in this case, is determined by integrating the charge beneath the oxidative peaks in the anodic stripping CV, assuming a one-electron transfer process for the oxidation.¹⁰

Number of active sites = $\frac{Q_{CV}}{96485 \ C \ per \ mole \ e^-} \times \frac{6.023 \times 10^{23} \ e^- \ per \ mole}{1 \ e^- \ per \ active \ site \ oxidised}$ Charge passed = $Q_{CV} = \int i_{CV} \ dt = 2.98 \times 10^{-3} \ C$

Hence,

$$TOF = \frac{(\frac{i}{96485 C \text{ per mole } e^{-}} \times \frac{6.023 \times 10^{23} e^{-} \text{ per mole}}{2 e^{-} \text{ per molecule of } H_{2}})}{(\frac{Q_{CV}}{96485 C \text{ per mole } e^{-}} \times \frac{6.023 \times 10^{23} e^{-} \text{ per mole}}{1 e^{-} \text{ per mole}})} = \frac{i}{2Q_{CV}} = \frac{1.51 \times 10^{-3}}{2 \times 2.98 \times 10^{-3}} = 0.25 \text{ s}^{-1}$$

The TOFs of H₂ evolution exhibited by MoS_x -AE and MoS_x -CE were an average of three measurements of each catalyst (Section 3.2).

S5. Cyclic voltammograms of MoS_x-AE and MoS_x-CE with graphite counter electrode



Figure S3: Cyclic voltammograms (cathodic sweep first) of (a) MoS_x -AE and (b) MoS_x -CE catalysts in 1 M HClO₄ electrolyte. Insets show a zoomed-in of the same curves. A graphite rod in lieu of a Pt counter electrode was used. Scan rate: 10 mV/s.

S6. Cyclic voltammograms of MoS_x-AE and MoS_x-CE at 0.5 mV/s during operando Raman spectroscopy measurements

Cyclic voltammograms of MoS_x -AE and MoS_x -CE were recorded at scan rates of 0.5 mV/s while operando Raman spectra were collected. Tafel slope values shown in the insets of Figures 2a(iii) and 2b(iii) were obtained from these CVs.



Figure S4: Cyclic voltammograms (cathodic sweep first) of (a) MoS_x -AE and (b) MoS_x -CE catalysts in 1 M HClO₄ and 1 M DClO₄ (containing 94.5 atom % D) electrolytes (the inset shows a zoomed-in of the MoS_x -AE reduction peak from the same curve). Scan rate: 0.5 mV/s.

S7. Raman spectra of electrodeposited MoS_x -AE, MoS_x -CE and crystalline MoS_2 in air



Figure S5: Raman spectra of crystalline MoS_2 (black curve), MoS_x -CE (red curve) and MoS_x -AE (blue curve) in air. MoS_x -CE and MoS_x -AE do not show the characteristic peaks of crystalline MoS_2 .^{11,12}



Figure S6: Raman spectra recorded from (a) MoS_x -AE and (b) MoS_x -CE catalysts during the (i) cathodic half sweep, and (ii) anodic half sweep of the cyclic voltammetry in 1 M DClO₄ (shown in section S6 of the Supporting Information, Figure S4). The signals marked with an asterisk originated from a cosmic ray.

S9. Operando Raman spectroscopy of Mo substrate in 1 M HClO₄

S9.1. Cyclic voltammogram of Mo substrate in 1 M HClO₄ at 0.5 mV/s



Figure S7: Cyclic voltammogram of Mo disc substrate in 1 M HClO₄. Scan rate: 0.5 mV/s.

S9.2. Raman spectra of Mo substrate collected during CV in 1 M HClO₄



Figure S8: Sequence of Raman spectra recorded from bare Mo substrate during the (a) cathodic half sweep, and (b) anodic half sweep of the cyclic voltammetry in 1 M HClO₄ (shown in Figure S7). The Raman peaks at 934 and 3000-3600 cm⁻¹ are vibrations of ClO₄⁻ and H₂O, respectively.¹³ The 2530 cm⁻¹ peak, attributed to v(S-H), is absent.

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